

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination KUIPERS ET AL.	
		Examiner Maribel Medina	Art Unit 1754	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-5,942,346	08-1999	Ahmed et al.	429/20
B	US-			
C	US-			
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Michalski et al., Temperature Measurement, 2nd Edition, John Wiley & Sons Ltd, pp. 209-228, 2001.
	V	Perry et al., Perry's Chemical Engineer's Handbook, 7th Edition McGraw-Hill, pp. 8-65 to 8-84, 1997.
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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